Applying the 5975 inert MSD to the Higher Molecular Weight Polybrominated Diphenyl Ethers (PBDEs)

Application





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Abstract

A previous application note presented results for analysis of the polybrominated diphenyl ethers (PBDEs) in polymers using the 5973N inert MSD [1]. Mass spectra were presented and interpreted for all of the important PBDEs. The new 5975 inert MSD provides many new features and improvements with expanded mass range to 1050 u being but one. This note presents the full spectra of the octa-, nona and decabrominated biphenyls ethers including ions that appear beyond the mass range of the previous 5973 MSD platform.

Introduction

PBDEs have become the "new PCBs" due to their widespread detection throughout the ecosystem. They have some structural and consequently mass spectral features in common with the polychlorinated biphenyls (PCBs) as well. The series of fragments formed by loss of chlorines (M-nCl₂) generates a number of intense ions useful in their determination. The PCBs also show relatively intense molecular ion clusters that assist in distinguishing the congeners. Similar attributes are expected and hoped for the PBDEs which show much more analytical difficulty than the PCBs.

This note presents the full scan spectra obtained for the PBDEs over the extended mass range of the 5975 inert MSD. The polymeric sample preparation and extraction protocols are cited elsewhere and supply two approaches to PBDE determinations [1].

Experimental

PBDE standards were acquired from Cambridge Isotope Laboratories (Andover, MA) and AccuStandard (New Haven, CT).

Instrumental Configuration and Conditions

The 6890 GC configuration and conditions are given in the previous application note [1]. The 5975 inert MSD system was operated in scan mode for acquisition of the PBDE spectra. The MSD scan operating parameters are cited in Table 1.

Table 1. 5975 inert MSD Configuration and Parameters

Mass spectrometer parameters

Ionization mode Electron impact
Ionization energy 70 eV
Tune parameters Autotune
Electron multiplier voltage Autotune + 400V
Scan mode 200–1000 u
Quadrupole temperature 150 °C
Inert source temperature 300 °C

Full conditions and parameters, as appropriate to the polymer analysis cited in reference 1, are available in the eMethod for this analysis (www.agilent.com/chem/emethods).



Results

El Spectra of the Higher Molecular Weight PBDEs

Figures 1, 2, and 3 present the full-scan spectra of an octa-, nona- and the decabromodiphenyl ether. Note that most intense ions in all cases are the $[M-Br_2]^*$ and the corresponding to $[M-Br_2]^{*2}$ ions. The relative abundance of the molecular ion clusters $[M]^*$ are under 30%. Figure 4 compares the

theoretical isotopic pattern to that experimentally obtained by the 5975 inert MSD. Agreement is good in both the abundance of the isotopes and the mass accuracy using the standard system Autotune. Mass accuracy agrees to within $0.2\ m/z$ of the theoretical and experimental values. Table 2 presents the important ions for the PBDEs greater than the dibromoDE. These ions are those most important to characterizing the technical mixtures used as additives to polymers.

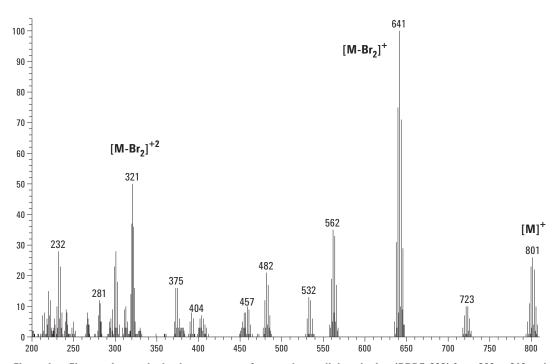


Figure 1. Electron impact ionization spectrum of an octabromodiphenyl ether (PBDE-203) from 200 to 810 m/z.

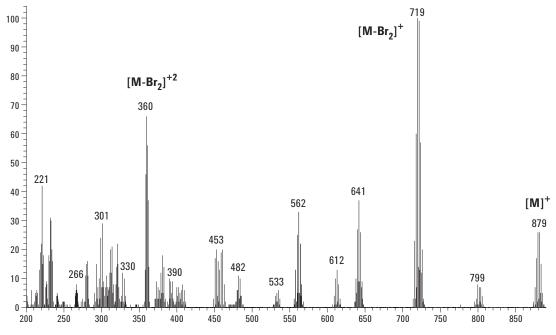


Figure 2. Electron impact ionization spectrum of a nonabromodiphenyl ether (PBDE-208) from 200 to 890 m/z.

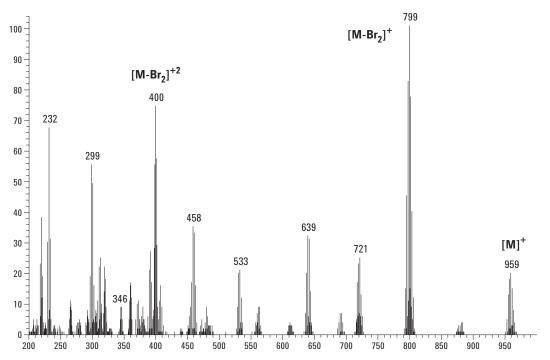


Figure 3. Electron impact ionization spectrum of the decabromodiphenyl ether (PBDE-209) from 200 to 1000 m/z.

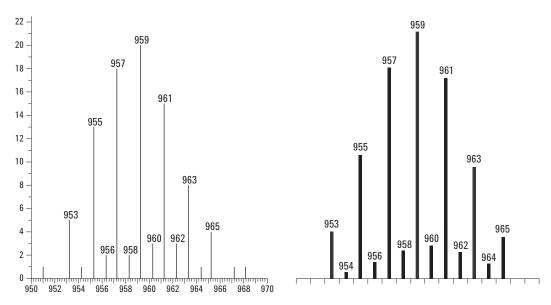


Figure 4. Experimental spectrum of the decabromodiphenyl ether (PBDE-209) molecular ion cluster [M]⁺ versus theory.

Table 2. Important lons for the PB_nDEs (n>2)

PBDE			_
bromination	[M] ⁺	$[M-Br_2]^+$	$[M-Br_2]^{+2}$
3	405.8	246.0	123.0
4	485.7	325.9	162.9
5	563.6	403.8	201.9
6	643.5	483.7	241.9
7	721.5	561.6	(280.8 **)
8	801.4	641.5	320.8
9	879.3	719.4	359.7
10	959.2	799.3	399.7

^{**}The 280.8 and 281.8 m/z ions can be compromised by column bleed interferences so these have not been used in acquisition although they provide a useful diagnostic for column degradation.

The user should note the ion source and quadrupole temperature settings in Table 1. Figure 5 presents SIM acquisitions of several higher molecular weight PBDEs at source temperatures of 300 °C and 230 °C. Notice the signal height roughly doubles on average for the PBDEs at the higher ion source temperature. The insert in the figure shows the improvement in the peak shape for the hexabrominated diphenyl ether. This peak sharpening accounts for the increase in signal height. Since these compounds elute at higher temperatures

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among other high boiling components that belong to the matrix, heating the quadrupole is important for robust and low maintenance operation in samples.

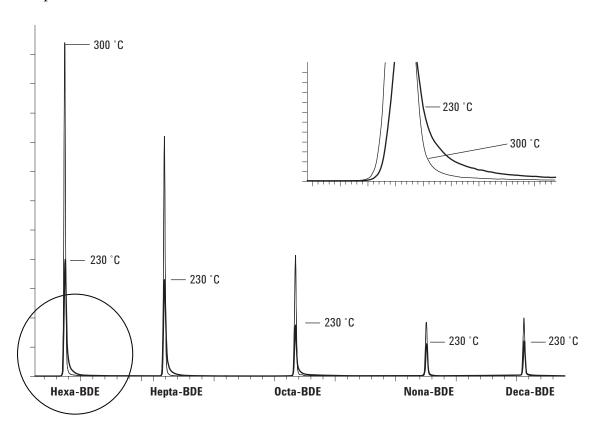


Figure 5. Overlaid RIC SIM acquisitions of five PBDEs at ion source temperatures of 230 °C and 300 °C. Insert is expanded view of hexa-BDE overlays near baseline.

Conclusions

The new 5975 inert MSD has an expanded set of features including mass range. High mass accuracy under standard autotuning is obtained even at the high masses typical of the brominated diphenyl ethers. As users survey higher mass compounds, the heated quadrupole and high temperature capabilities of the 5975 inert MSD will become even more important to rugged and robust analyses in complicated samples.

More details on the other relevant instrumental parameters are available in the eMethod (www.agilent.com/chem/emethods).

Reference

 C. Tu, and H. Prest, Determination of polybrominated diphenyl ethers in polymeric materials using the 6890 GC/5973N Inert MSD with electron impact ionization. Agilent Technologies, publication 5989-2850EN, www.agilent.com/chem

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Printed in the USA June 13, 2005 5989-3142EN

